

ATC ENVIRONMENTAL, INC.
104 East 25th Street
New York, NY 10010

APPROVED NY STATE DOH ELAP # 10879
ACCREDITED NVLAP Lab Code # 1187

Summary of TEM Results

N.Y.C. Board of Education
28-11 Queens Plaza North
Long Island City, NY 11101
Mr. Bernard Orlan

DATE: 10/18/01

Project/Site Identification: New Stuyvesant H.S., 345 Chambers St., NY, NY
Exterior & Interior of Building & Roof

CONCLUSION:

STATISTICAL SUMMARY

1) Inside Samples

TEM#	Project #	Volume (l)	<u>Asbestos Concentration</u>		
			S/mm ²	S/cc	ngm/m ³
5716- 61540	NSHS-EIR-10/17-8	1899	0.0	0.0045 *	
5716- 61541	NSHS-EIR-10/17-9	1899	0.0	0.0045 *	
5716- 61542	NSHS-EIR-10/17-10	1908	0.0	0.0045 *	
5716- 61543	NSHS-EIR-10/17-11	1899	0.0	0.0045 *	
5716- 61544	NSHS-EIR-10/17-12	1899	0.0	0.0045 *	
Average=			0.0	0.0045	0

2) Outside Samples

TEM#	Project #	Volume (l)	<u>Asbestos Concentration</u>		
			S/mm ²	S/cc	ngm/m ³
5716- 61533	NSHS-EIR-10/17-1	1899	0.0	0.0045 *	
5716- 61534	NSHS-EIR-10/17-2	1899	0.0	0.0045 *	
5716- 61535	NSHS-EIR-10/17-3	1890	0.0	0.0045 *	
5716- 61536	NSHS-EIR-10/17-4	1899	0.0	0.0045 *	
5716- 61537	NSHS-EIR-10/17-5	1899	0.0	0.0045 *	
5716- 61538	NSHS-EIR-10/17-6	1899	0.0	0.0045 *	
5716- 61539	NSHS-EIR-10/17-7	1908	0.0	0.0045 *	
Average=			0.0	0.0045	0

3) Blanks

TEM#	Project #	<u>Asbestos Concentration</u>		
		S/mm ²	S/cc	ngm/m ³
5716- 61545	NSHS-EIR-10/17-13	- - - - -	Not Analyzed	- - - - -
5716- 61546	NSHS-EIR-10/17-14	- - - - -	Not Analyzed	- - - - -
5716- 61547	NSHS-EIR-10/17-15	- - - - -	Not Analyzed	- - - - -
Average=		N/A	N/A	N/A

4) Value of T - Statistic: N/A

* None detected; concentration equivalent to analytical sensitivity assigned.

This test report relates only to the specific items cited in the analysis.

The analysis was carried out according to the approved TEM method. The laboratory is in compliance with the quality specified for the method.

This report must not be used by the client to claim product endorsement by NVLAP or any agency of the U.S. Government.

Analyzed by:
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